

Field Stop Trench IGBT 650 V, 40 A FGA40T65SHD

General Description

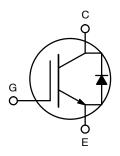
Using novel field stop IGBT technology, **onsemi**'s new series of field stop 3rd generation IGBTs offer the optimum performance for solar inverter, UPS, welder, telecom, ESS and PFC applications where low conduction and switching losses are essential.

Features

- Maximum Junction Temperature: $T_J = 175$ °C
- Positive Temperature Co-efficient for Easy Parallel Operating
- High Current Capability
- Low Saturation Voltage: $V_{CE(sat)} = 1.6 \text{ V (Typ.)}$ @ $I_C = 40 \text{ A}$
- 100% of the Parts Tested for I_{LM}(1)
- High Input Impedance
- Fast Switching
- Tighten Parameter Distribution
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

• Solar Inverter, UPS, Welder, Telecom, ESS, PFC





TO-3P-3LD CASE 340BZ

MARKING DIAGRAM



FGA40T65SHD = Specific Device Code
A = Assembly Location
YWW = Date Code (Year & Week)
ZZ = Assembly Lot

ORDERING INFORMATION

Device	Package	Shipping
FGA40T65SHD	TO-3P-3LD (Pb-Free / Halide Free)	450 Units / Tube

ABSOLUTE MAXIMUM RATINGS ($T_C = 25$ °C unless otherwise noted)

Symbol	Description	Value	Unit	
V _{CES}	Collector to Emitter Voltage	650	V	
V _{GES}	Gate to Emitter Voltage	±20	Α	
	Transient Gate to Emitter Voltage		±30	Α
I _C	Collector Current	@ T _C = 25°C	80	Α
	Collector Current	@ T _C = 10°C	40	Α
I _{LM} (Note 1)	Pulsed Collector Current	@ T _C = 25°C		Α
I _{CM} (Note 2)	Pulsed Collector Current	120	Α	
I _F	Diode Forward Current	@ T _C = 25°C	40	Α
	Diode Forward Current	@ T _C = 100°C	20	Α
I _{FM} (Note 2)	Pulsed Diode Maximum Forward Current	Diode Maximum Forward Current		
P_{D}	Maximum Power Dissipation	@ T _C = 25°C	268	W
	Maximum Power Dissipation	@ T _C = 10°C	134	W
TJ	Operating Junction Temperature	-55 to +175	°C	
T _{stg}	Storage Temperature Range	-55 to +175	°C	
T _L	Maximum Lead Temp. for soldering Purposes, 1/8" from case	300	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 1. V_{CC} = 400 V, V_{GE} = 15 V, I_{C} = 120 A, R_{G} = 30 Ω , Inductive Load. 2. Repetitive rating: Pulse width limited by max. junction temperature.

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{\theta JC}$ (IGBT)	Thermal Resistance, Junction to Case, Max.	0.56	°C/W
$R_{\theta JC}$ (Diode)	Thermal Resistance, Junction to Case, Max.	1.71	°C/W
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient, Max.	40	°C/W

ELECTRICAL CHARACTERISTICS OF THE DIODE (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Unit
V_{FM}	Diode Forward Voltage	I _F = 20 A	T _C = 25°C	-	2.2	2.8	V
			T _C = 175°C	-	1.94	-	
E _{rec}	Reverse Recovery Energy	I _F = 20 A, dI _F /dt = 200 A/μs	T _C = 175°C	-	50	-	μJ
t _{rr}	Diode Reverse Recovery Time	αιρ/αι = 200 //μο	T _C = 25°C	-	31.8	-	ns
			T _C = 175°C	-	192	-	
Q _{rr}	Diode Reverse Recovery Charge		T _C = 25°C	-	50.6	-	nC
			T _C = 175°C	-	699	-	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

ELECTRICAL CHARACTERISTICS OF THE IGBT (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
OFF CHARAC	TERISTICS	•	•		•	
BV _{CES}	Collector to Emitter Breakdown Voltage	$V_{GE} = 0 \text{ V}, I_{C} = 1 \text{ mA}$	650	-	_	V
ΔBV_{CES} / ΔT_{J}	Temperature Coefficient of Breakdown Voltage	I _C = 1 mA, Reference to 25°C	-	0.6	-	V/°C
I _{CES}	Collector Cut-Off Current	V _{CE} = V _{CES} , V _{GE} = 0 V	-	-	250	μΑ
I _{GES}	G-E Leakage Current	V _{GE} = V _{GES} , V _{CE} = 0 V	-	-	±400	nA
ON CHARACT	ERISTICS					
V _{GE(th)}	G-E Threshold Voltage	I_C = 40 mA, V_{CE} = V_{GE}	3.5	5.5	7.5	V
V _{CE(sat)}	Collector to Emitter Saturation Voltage	I _C = 40 A, V _{GE} = 15 V	-	1.6	2.1	V
		I _C = 40 A, V _{GE} = 15 V, T _C = 175°C	-	2.14	-	V
DYNAMIC CHA	ARACTERISTICS		•	•		•
C _{ies}	Input Capacitance	V _{CE} = 30 V, V _{GE} = 0 V,	-	1995	_	pF
C _{oes}	Output Capacitance	f = 1 MHz	_	70	_	pF
C _{res}	Reverse Transfer Capacitance		_	23	_	pF
SWITCHING C	HARACTERISTICS	•		<u> </u>	<u>.</u>	
t _{d(on)}	Turn-On Delay Time	$V_{CC} = 400 \text{ V, } I_{C} = 40 \text{ A,}$ $R_{G} = 6 \Omega, V_{GE} = 15 \text{ V,}$ Inductive Load, $T_{C} = 25^{\circ}\text{C}$	-	19.2	_	ns
t _r	Rise Time		-	34.4	_	ns
t _{d(off)}	Turn-Off Delay Time		_	65.6	_	ns
t _f	Fall Time		-	9.6	_	ns
E _{on}	Turn-On Switching Loss		-	1010	_	μJ
E _{off}	Turn-Off Switching Loss		-	297	_	μJ
E _{ts}	Total Switching Loss		-	1307	-	μJ
t _{d(on)}	Turn-On Delay Time	$V_{CC} = 400 \text{ V}, I_{C} = 40 \text{ A},$	-	18.4	-	ns
t _r	Rise Time	$R_G = 6 \Omega$, $V_{GE} = 15 V$, Inductive Load, $T_C = 175$ °C	_	32.8	_	ns
t _{d(off)}	Turn-Off Delay Time		_	71.2	_	ns
t _f	Fall Time		_	14.4	_	ns
E _{on}	Turn-On Switching Loss		_	1390	_	μJ
E _{off}	Turn-Off Switching Loss		-	541	-	μJ
E _{ts}	Total Switching Loss		_	1931	_	μЈ
Qg	Total Gate Charge	V _{CE} = 400 V, I _C = 40 A,	-	72.2	-	nC
Q _{ge}	Gate to Emitter Charge	V _{GE} = 15 V	_	13.5	_	nC
Q _{gc}	Gate to Collector Charge		_	28.5	_	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL PERFORMANCE CHARACTERISTICS

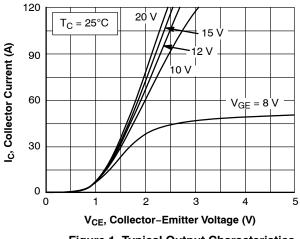


Figure 1. Typical Output Characteristics

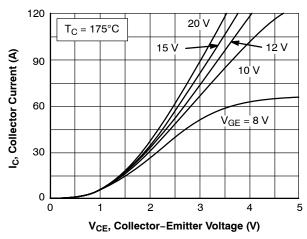


Figure 2. Typical Output Characteristics

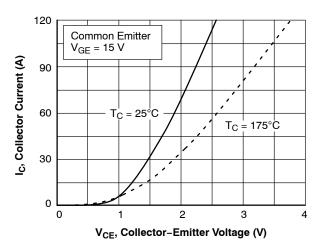


Figure 3. Typical Saturation Voltage Characteristics

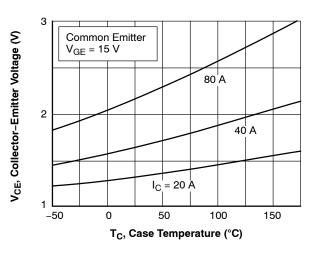


Figure 4. Saturation Voltage vs. Case Temperature at Variant Current Level

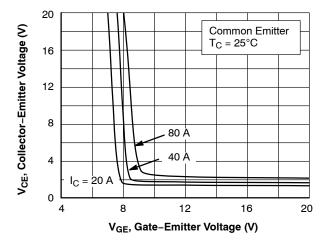


Figure 5. Saturation Voltage vs. V_{GE}

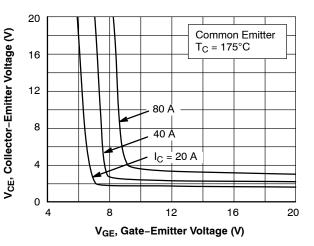


Figure 6. Saturation Voltage vs. V_{GE}

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

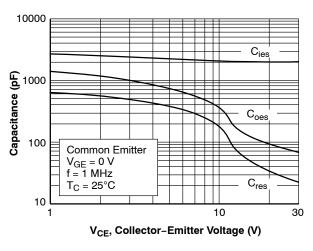


Figure 7. Capacitance Characteristics

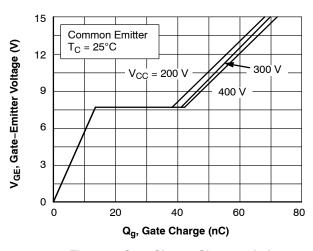


Figure 8. Gate Charge Characteristics

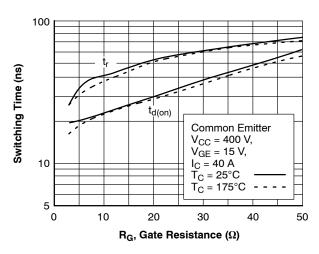


Figure 9. Turn-on Characteristics vs. Gate Resistance

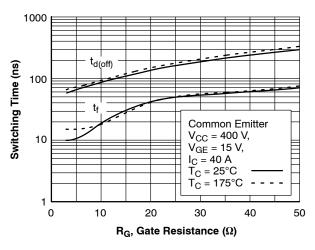


Figure 10. Turn-off Characteristics vs. Gate Resistance

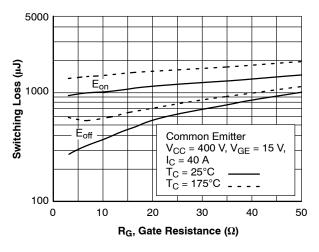


Figure 11. Switching Loss vs. Gate Resistance

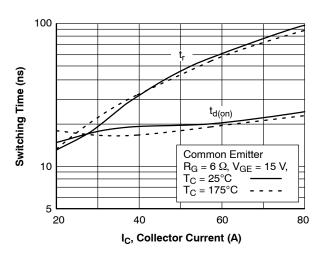


Figure 12. Turn-on Characteristics vs. Collector Current

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

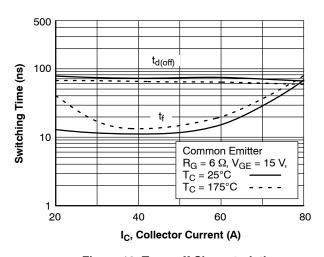


Figure 13. Turn-off Characteristics vs. Collector Current

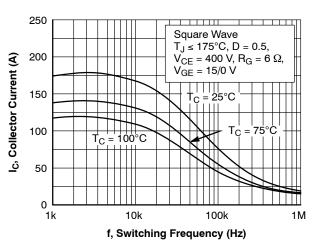


Figure 15. Load Current Vs. Frequency

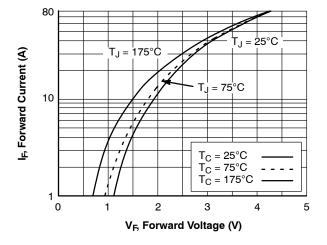


Figure 17. Forward Characteristics

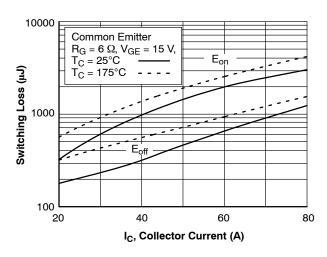


Figure 14. Switching Loss vs. Collector Current

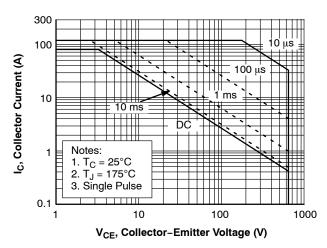


Figure 16. SOA Characteristics

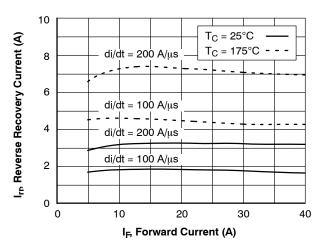


Figure 18. Reverse Recovery Current

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

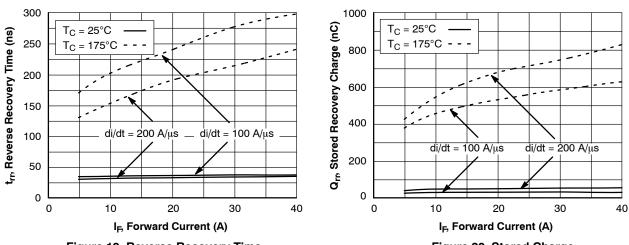


Figure 19. Reverse Recovery Time

Figure 20. Stored Charge

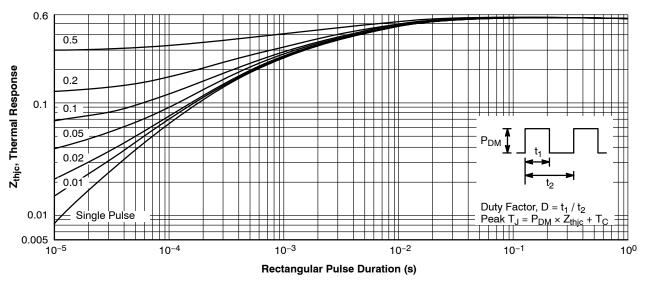


Figure 21. Transient Thermal Impedance of IGBT

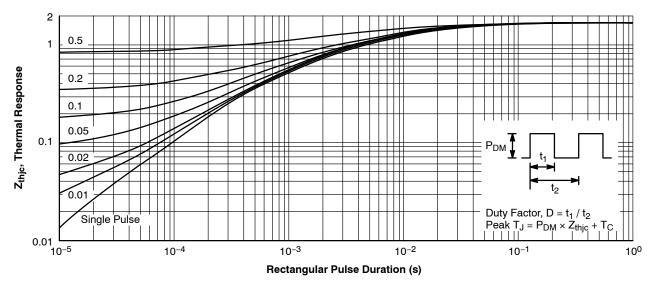
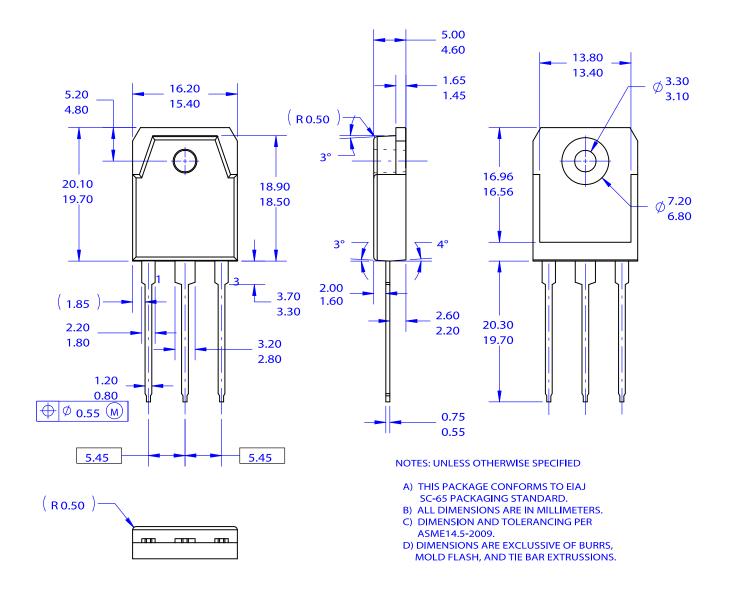


Figure 22. Transient Thermal Impedance of Diode

TO-3P-3LD / EIAJ SC-65, ISOLATED CASE 340BZ ISSUE O

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